


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/617,741	HIROTA, HISATOSHI	
	Examiner	Art Unit	
	Huyen Le	3751	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
251		129.07							
INTERNATIONAL CLASSIFICATION									
F	1	6	K	31/02					
				/					
				/					
				/					
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<i>Huyen Le</i> Huyen Le 1/20/06 (Assistant Examiner) (Date)	<i>Justin Z</i> 1/20/06 JUSTINE R. YU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Priority Examiner) (Date)	Total Claims Allowed: 24 O.G. Print Claim(s) 20	O.G. Print Fig. 1
<i>Nicole P. Smith</i> 1-24-06 (Legal Instruments Examiner) (Date)			

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47							
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		91		121		151		181
2	2		32		62		92		122		152		182
20	3		33		63		93		123		153		183
21	4		34		64		94		124		154		184
3	5		35		65		95		125		155		185
22	6		36		66		96		126		156		186
23	7		37		67		97		127		157		187
24	8		38		68		98		128		158		188
4	9		39		69		99		129		159		189
5	10		40		70		100		130		160		190
6	11		41		71		101		131		161		191
7	12		42		72		102		132		162		192
8	13		43		73		103		133		163		193
9	14		44		74		104		134		164		194
10	15		45		75		105		135		165		195
11	16		46		76		106		136		166		196
12	17		47		77		107		137		167		197
13	18		48		78		108		138		168		198
14	19		49		79		109		139		169		199
15	20		50		80		110		140		170		200
16	21		51		81		111		141		171		201
17	22		52		82		112		142		172		202
18	23		53		83		113		143		173		203
19	24		54		84		114		144		174		204
	25		55		85		115		145		175		205
	26		56		86		116		146		176		206
	27		57		87		117		147		177		207
	28		58		88		118		148		178		208
	29		59		89		119		149		179		209
	30		60		90		120		150		180		210